

4M x 4Banks x 8bits SDRAM 2M x 4Banks x 16bits SDRAM

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1. GENERAL DESCRIPTION

PT481608FHG is organized as 4M words x 4 banks x 8 bits Synchronous DRAM with LVTTL interface and PT480816FHG is organized as 2M words x 4 banks x 16 bits. All inputs and outputs are referenced to the rising edge of CLK. PT481608FHG and PT480816FHG achieve very high speed data rates up to 166MHz, and are suitable for main memories or graphic memories in computer systems.

2. FEATURES

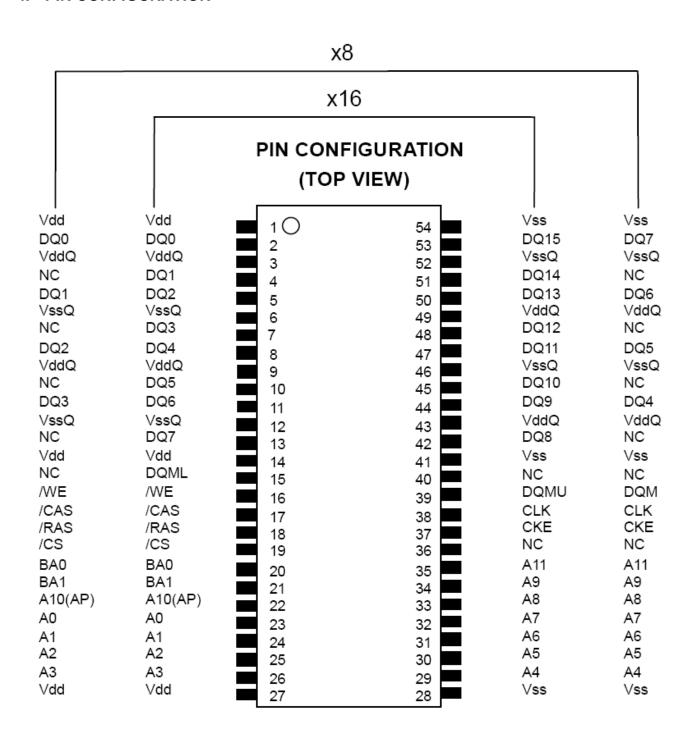
- 3.3V \pm 0.3V power supply
- Maximum clock frequency:
- -6:166MHz<3-3-3> / -7:143MHz<3-3-3> / -75:133MHz<3-3-3>
- Fully synchronous operation referenced to clock rising edge
- 4-bank operation controlled by BA0, BA1 (Bank Address)
- /CAS latency- 2/3 (programmable)
- Burst length- 1/2/4/8/FP (programmable)
- Burst type- Sequential and interleave burst (programmable)
- Byte Control- DQM(PT481608FHG), DQML and DQMU(PT480816FHG)
- Random column access
- Auto precharge / All bank precharge controlled by A10
- Support concurrent auto-precharge
- Auto and self refresh
- 4096 refresh cycles /64ms
- LVTTL Interface
- Package
 400-mil, 54-pin Thin Small Outline (TSOP II) with 0.8mm lead pitch using PB-free with RoHS compliant

3. PART NUMBER INFORMATION

PART NUMBER	SPEED (CL=3)	SUPPLY VOLTAGE
PT481608FHG-6	166MHz	3.3V
PT481608FHG-7	143MHz	3.3V
PT481608FHG-75	133MHz	3.3V
PT480816FHG -6	166MHz	3.3V
PT480816FHG -7	143MHz	3.3V
PT480816FHG -75	133MHz	3.3V



4. PIN CONFIGURATION



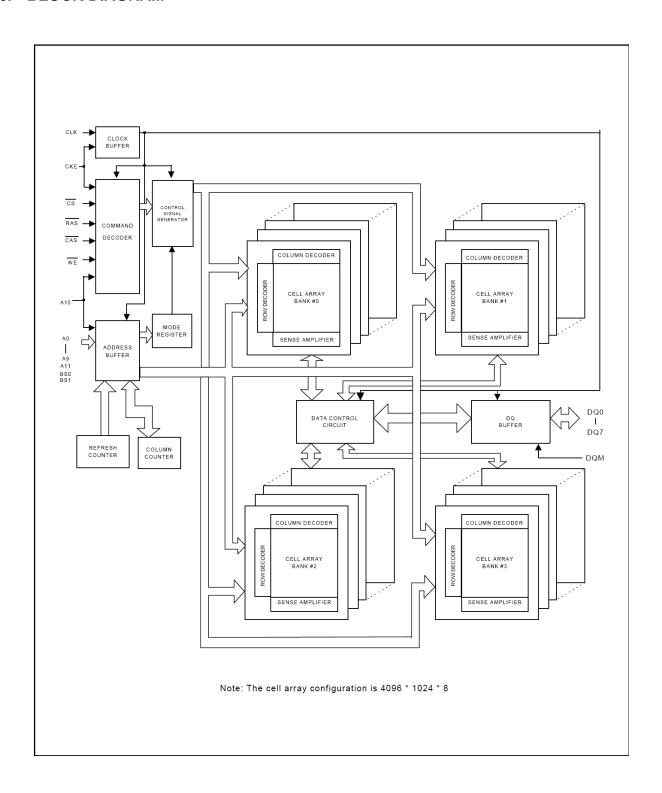


5. PIN DESCRIPTION

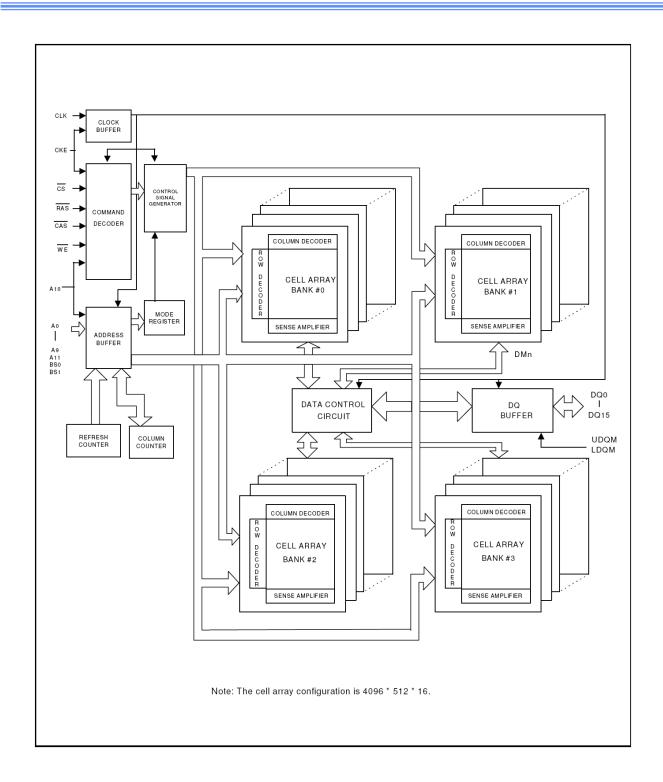
SYMBOL	TYPE	DESCRIPTION
CLK	Input	Clock: CLK is driven by the system clock. All SDRAM input signals are sampled on the positive edge of CLK. CLK also increments the internal burst counter and controls the output registers.
CKE	Input	Clock Enable: CKE activates (HIGH) and deactivates (LOW) the CLK signal. Deactivating the clock provides PRECHARGE POWER-DOWN and SELF REFRESH operation (all banks idle), ACTIVE POWER-DOWN (row active in any bank), DEEP POWER DOWN (all banks idle), or CLOCK SUSPEND operation (burst/access in progress). CKE is synchronous except after the device enters power-down and self refresh modes, where CKE becomes asynchronous until after exiting the same mode. The input buffers, including CLK, are disabled during ower-down and self refresh modes, providing low standby power. CKE may be tied HIGH.
/CS	Input	Chip Select: /CS enables (registered LOW) and disables (registered HIGH) the command decoder. All commands are masked when /CS is registered HIGH. /CS provides for external bank selection on systems with multiple banks. /CS is considered part of the command code.
/CAS, /RAS, /WE	Input	Command Inputs: /CAS, /RAS, and /WE (along with /CS) define the command being entered.
DQM, DQML, DQMU	Input	Input/Output Mask: DQM is sampled HIGH and is an input mask signal for write accesses and an output enable signal for read accesses. Input data is masked during a WRITE cycle. The output buffers are placed in a High-Z state (two-clock latency) when during a READ cycle. DQM corresponds to DQ0–DQ7 (PT481608FHG), DQML corresponds to DQ0–DQ7, DQMU corresponds to DQ8–DQ15 (PT480816FHG).
BA0, BA1	Input	Bank Address Input(s): BA0 and BA1 define to which bank the ACTIVE, READ, WRITE or PRECHARGE command is being applied. These pins also select between the mode register and the extended mode register.
A0-A11	Input	A0-12 specify the Row / Column Address in conjunction with BA0,1. The Row Address is specified by A0-11. The Column Address is specified by A0-9 (x8) and A0-A8 (x16). A10 is also used to indicate precharge option. When A10 is high at a read / write command, an auto precharge is performed. When A10 is high at a precharge command, all banks are precharged.
DQ0-DQ15	I/O	Data Input/Output: Data bus.
NC	_	Internally Not Connected: These could be left unconnected, but it is recommended they be connected or Vss.
VDDQ	Supply	DQ Power: Provide isolated power to DQs for improved noise immunity.
VssQ	Supply	DQ Ground: Provide isolated ground to DQs for improved noise immunity.
VDD	Supply	Core Power Supply.
Vss	Supply	Ground.



6. BLOCK DIAGRAM









7. ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	Note
Voltage on any pin relative to Vss	VIN,VOUT	-1.0 ~ 4.6	V	
Voltage on VDD supply relative to Vss	VDD, VDDQ	-1.0 ~ 4.6	V	
Operating Ambient Temperature	Та	0 ~ 70	°C	
Storage temperature	TSTG	-55 ~ 150	°C	
Power dissipation	PD	1.0	W	
Short circuit current	IOS	50	mA	

Note:

- 1. Permanent device damage may occur if ABSOLUTE MAXIMUM RATINGS are exceeded.
- 2. Functional operation should be restricted to recommended operating condition.
- 3. Exposure to higher than recommended voltage for extended periods of time could affect device reliability.

8. DC OPERATING CONDITIONS

Recommended operating conditions (Voltage referenced to VSS = 0V, TA = 0 to 70°C)

Parameter	Symbol	Min	Тур	Max	Unit	Note
Supply voltage	Vdd	3.0	3.3	3.6	V	
Supply voltage	VddQ	3.0	3.3	3.6	V	
Input logic high voltage	VIH	2.0	Vdd	Vdd + 0.3	V	1
Input logic low voltage	VIL	-0.3	0	0.8	V	2
Output logic high voltage	VOH	2.4	-	-	V	IOH = -2mA
Output logic low voltage	VOL	-	-	0.4	V	IOL = 2mA
Input leakage current	IIL	-10	-	10	uA	3
Output leakage current	IOL	-10	-	10	uA	3

Note:

- 1. VIH(max) = 4.6V AC for pulse width ≤ 10 ns acceptable.
- 2. VIL(min) = -1.5V AC for pulse width ≤ 10 ns acceptable.
- 3. Any input $0V \le VIN \le VDD + 0.3V$, all other pins are not under test = 0V.
- 4. Dout is disabled, 0V ≤ VOUT ≤ VDD.

9. CAPACITANCE

(Vdd = VddQ = 3.3V, TA = 25°C, f = 1MHz, pin under test biased at 1.4V.)

Parameter	Symbol	Min	Max	Unit	Note
Clock	Cclk	2	3.5	pF	
/CAS,/RAS,/WE,/CS,CKE,DQMU/L	Cin	2	3.5	pF	
Address	CADD	2	3.5	рF	
DQ0~DQ15	COUT	3.5	5.5	pF	



10. DC CHARACTERISTICS

(Recommended operating conditions unless otherwise noted, TA = 0 to 70°C)

Parameter	Symbol	Test Condition	Organization	-6	-7	-75	Unit	Note
Operating Current	Icc1	Burst length = 2 tRC = tRC(min)	x8	105	105	100		1
(One Bank Active)		IO = 0 mA	x16	110	110	105		•
Precharge Standby	Icc2P	CKE = VIL(max), tCC = 10ns	x8 / x16		12			
Current in power-down mode	Icc2PS	CKE & CLK = VIL(max), tCC = ∞	x8 / x16		5			
Precharge Standby Current in non power-down	Icc2N	CKE = VIH(min), CS = VIH(min), tCC = 10ns Input signals are changed one time during 20ns	x8 / x16	38				
mode	Icc2NS	CKE = VIH(min), CLK = VIL(max), tCC = ∞ Input signals are stable	x8 / x16 28			28		
Active Standby Current in	Icc3P	CKE = VIL(max), tCC = 10ns	x8 / x16		35			
power-down mode (One Bank Active)	Icc3PS	CKE & CLK = VIL(max), tCC x8 / x16 20			mA			
Active Standby Current in non power-down mode	Icc3N	CKE = VIH(min), CS = VIH(min), tCC = 10ns Input signals are changed one time during 20ns	x8 / x16		65			
(One Bank Active)	Icc3NS	CKE = VIH(min), CLK = VIL(max), tCC = ∞ Input signals are stable	x8 / x16	45				
Operating Current (Burst Mode)	Icc4	O = 0 mA Page burst 4Banks Activated CCD = 2CLKs			1			
Refresh Current	lcc5	tARFC = tARFC(min) x8 / x16 150				130		2
Self Refresh Current	Icc6	CKE = 0.2V	x8 / x16	6	6	6		

Note:

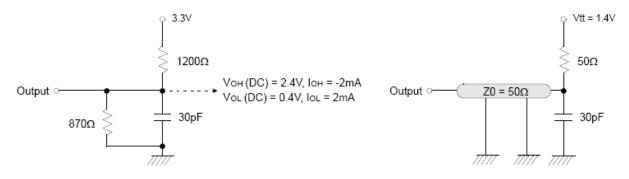
- 1. Measured with outputs open.
- 2. Refresh period is 64ms.
- 3. Unless otherwise noted, input swing level is CMOS(VIH /VIL=VDDQ/VSSQ).



11. AC OPERATING TEST CONDITIONS

(VDD = VddQ = $3.3V \pm 0.3V$, TA = 0 to 70° C)

Parameter	Value	Unit
AC input levels (Vih/Vil)	2.4 / 0.4	V
Input timing measurement reference level	1.4	V
Input rise and fall time	tr/tf = 1/1	ns
Output timing measurement reference level	1.4	V
Output load condition	See Figure 2	



(Fig. 1) DC output load circuit

(Fig. 2) AC output load circuit



12. OPERATING AC PARAMETER

(AC operating conditions unless otherwise noted)

Parameter	Symbol	-6	-7	-75	Unit	Note
Row active to row active delay	tRRD(min)	12	14	15	ns	1
RAS to CAS delay	tRCD(min)	18	20	20	ns	1
Row precharge time	tRP(min)	18	20	20	ns	1
Davidadina tiana	tRAS(min)	42	45	45	ns	1
Row active time	tRAS(max)	100	100	100	us	
Row cycle time	tRC(min)	60	63	65	ns	1
Last data in to row precharge	tRDL(min)	2	2	2	CLK	2
Last data in to Active delay	tDAL(min)	5	5	5	CLK-	
Last data in to new col. address delay	tCDL(min)	1	1	1	CLK	2
Last data in to burst stop	tBDL(min)	1	1	1	CLK	2
Mode register set cycle time	tMRD(min)	2	2	2	CLK	
Refresh interval time	tREF(max)	64	64	64	ms	
Auto refresh cycle time	tARFC(min)	60	70	75	ns	

Note:

- 1. The minimum number of clock cycles is determined by dividing the minimum time required with clock cycle time and then rounding off to the next higher integer.
- 2. Minimum delay is required to complete write.



13. AC CHARACTERISTICS

(AC operating conditions unless otherwise noted)

Parameter			-	6	-	7	-7	75	11:4	Note
Paramete	er	Symbol	Min	Max	Min	Max	Min	Max	Unit	Note
CLK cycle time	CAS latency=3	tCC(3)	6		7		7.5			1
our cycle time	CAS latency=2	tCC(2)	10		10		10			'
CLK to valid output delay	CAS latency=3	tSAC(3)		5.4		5.4		5.4		1,2
CLK to valid output delay	CAS latency=2	tSAC(2)		5.4		5.4		6		1,2
Output data hold time	CAS latency=3	tOH(3)	2.5		2.5		2.5			2
Output data hold time	CAS latency=2	tOH(2)	2.5		2.5		2.5			۷
CLK high pulse width		tCH	2.5		2.5		2.5			3
CLK low pulse width		tCL	2.5		2.5		2.5		ns	3
Input setup time		tSI	1.5		1.5		1.5			3
Input hold time		tHI	1		1		1			3
Transition time of CLK		tΤ	0.3	1.5	0.3	1.5	0.3	1.5		
CLK to output in Low-Z		tSLZ	1		1		1			
CLK to output in Hi-Z	CAS latency=3	tSHZ		5.4		5.4		5.4		
OLIV to output in r ii-2	CAS latency=2	IOI IZ		5.4		5.4		6		

Note:

- 1. Parameters depend on programmed CAS latency.
- 2. If clock rising time is longer than 1ns, (tr/2-0.5)ns should be added to the parameter.
- 3. Assumed input rise and fall time (tr & tf) = 1ns.

 If tr & tf is longer than 1ns, transient time compensatio should be considered, ni.e., [(tr + tf)/2-1]ns should be added to the parameter.



14. TRUTH TABLE

14.1. Command Truth Table

COMMAND	Symbol	CKEn-1	CKEn	cs	RAS	CAS	WE	BA1	BA0	A10/ AP	A9-0 A11
Device Deselect	DSL	Н	X	Н	Х	Х	Χ	Χ	Х	Χ	Χ
No-Operation	NOP	Н	X	L	Н	Н	Н	Χ	Х	Χ	Χ
Burst Stop	BST	Н	X	L	Н	Н	L	Χ	Х	Χ	Χ
Read	RD	Н	Х	L	Н	L	Н	V	V	L	V
Read with Auto precharge	RDA	Н	Х	L	Н	L	Н	٧	V	Н	V
Write	WR	Н	Χ	L	Н	L	L	V	V	L	V
Write with Auto precharge	WRA	Н	Х	L	Н	L	L	V	V	Н	V
Bank activate	ACT	Н	Χ	L	L	Н	Н	٧	V	V	V
Precharge select bank	PRE	Н	Х	L	L	Н	L	V	V	L	Х
Precharge all bank	PALL	Н	Х	L	L	Н	L	Χ	Х	Н	Х
Mode Register Set	MRS	Н	Х	L	L	L	L	L	L	L	OP code

(V=Valid, X=Don't Care, H=Logic High, L=Logic Low)

14.2. CKE Truth Table

Current state	Function	Symbol	CKEn-1	CKEn	/cs	/RAS	/CAS	/WE	Address
Activating	Enter Clock suspend or		Н	L	L	V	V	V	V
, touvaing	Active power down		Н	L	Н	Χ	Χ	Χ	X
Clock suspend or Active power down	Maintain Clock suspend or Active power down		L	L	Х	Х	Х	х	х
Clock suspend or Active power down	Exit Clock suspend or Active power down		L	Н	X	Х	Х	Х	X
All banks idle	Auto refresh command	REF	Н	Н	L	L	L	Н	X
All banks idle	Enter Self refresh	SREF	Н	L	L	L	L	Н	X
All banks idle	Enter Precharge Power		Н	L	L	Н	Н	Н	Х
	down		Н	L	Н	Х	Х	Х	Х
Self refresh	Exit Self refresh		L	Н	L	Н	Н	Н	Х
			L	Н	Н	Х	X	Х	X
Precharge Power	Exit Precharge Power		L	Н	L	Н	Н	Н	X
down	down		L	Н	Н	Х	X	Х	X
Precharge Power down	Maintain Precharge power down		L	L	Х	Х	Х	Х	X

(V=Valid, X=Don't Care, H=Logic High, L=Logic Low)



14.3. Function Truth Table

/CS	/RAS	/CAS	/WE	/Address	Command	Action	Notes
Н	X	Х	Χ	Х	DESL	NOP	
L	Н	Н	Н	X	NOP	NOP	
L	Н	Н	L	, ·	BST	ILLEGAL	2
L	Н	L	Н	BA,CA,A10	RD/RDA	ILLEGAL	2
L	Н	L	L	BA,CA,A10		ILLEGAL	2
L	L	Н	H	BA,RA		Bank active	
L	L	Н	L	BA,A10	PRE/PALL	NOP	4
L	L	L	Н	X	REF	Auto refresh	5
L	L	L	L		MRS	Mode register set	5
Н							
L			Н				
L	Н	Н	L	X	BST	ILLEGAL	2
L	Н	L	Н	BA,CA,A10	RD/RDA	Begin read, determine AP	
L	Н	L	L		WR/WRA	Begin write, determine AP	
L	L	Н	Η	BA,RA	ACT	Bank active / ILLEGAL	2
L	L	Н	L	BA,A10	PRE/PALL	Precharge / Precharge all banks	
L	L	L	Η	Χ	REF	ILLEGAL	
L	L	L	L	OC	MRS	ILLEGAL	
Н	Χ	Х	Χ	Х	DESL	Continue burst to end	
L	Н	Н	Н	Х	NOP	Continue burst to end	
L	Н	Н	L	Х		Terminate burst	
L		L	Н	BA.CA.A10		Terminate burst, begin read, determine AP	3
L		L	L				3
		Н	Н				2
<u>- </u>	ī		ı		_		-
<u>- </u>	ī	i	H				
<u>- </u>	ī	ī	ı				
<u>-</u>	X	X	X				
<u>-</u>			1				
<u>-</u>		i	H	-			3
<u>-</u>		<u> </u>	1				3
<u>-</u>	i	Н	Н				2
<u>- </u>	i i		1				
<u>- </u>	ı	i .	L L				
<u>- </u>	i i	<u> </u>	1				
<u>-</u> Н	Υ	Υ	Υ				
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<u> </u>	L V	L V	L		DECL		
<u> </u>			<u> </u>				1
<u> </u>		lH	L				
<u>L</u>		<u>L</u>	H				2
<u>L</u>	H -	<u>L</u>	L				2
L	L		H				2
			11	BA,A10	PRE/PALL	ILLEGAL	2
<u>L </u>	L	H	Н	X	REF	ILLEGAL	+
	H L L L L L	H X L H L H L L L L L L L L L L L L L L L L	H X X X L H H H L H L L H L L H L L H L L H L L H L L H L L H L L H H L L H L L H L L H L H L H H L H H L H L H H L H L H H L H	H X X X X X X L H H H L L L L L L L L L	H X X X X X X X X X X X X X X X X X X X	X	H



Current state	/CS	/RAS	/CAS	/WE	/Address	Command	Action	Notes
Precharging	Н	X	Х	Х	X	DESL	NOP, idle after tRP	
	L	Н	Н	Н	Χ	NOP	NOP, idle after tRP	
	L	Н	Н	L	Χ	BST	ILLEGAL	2
	L	Н	L	Н	BA,CA,A10	RD/RDA	ILLEGAL	2
	L	Н	L	L	BA,CA,A10	WR/WRA	ILLEGAL	2
	L	L	Н	Н	BA,RA	ACT	Bank active / ILLEGAL	2
	L	L	Н	L	BA,A10	PRE/PALL	Nop, idle after tRP	4
	L	L	L	Н	X	REF	ILLEGAL	
	L	L	L	L	OC	MRS	ILLEGAL	
Row activating	Н	Х	Х	Х	X	DESL	NOP, row active after tRCD	
	L	Н	Н	Н	Х	NOP	NOP, row active after tRCD	
		Н	Н		X	BST	ILLEGAL	2
		H	i	H	BA,CA,A10	RD/RDA	ILLEGAL	2
	L	H	Ĺ	Ĺ	BA,CA,A10	WR/WRA	ILLEGAL	2
	L	Ĺ	H	<u>-</u> Н	BA,RA	ACT	ILLEGAL	2
		Ī	H	i	BA,A10	PRE/PALL	ILLEGAL	2
	<u> </u>	<u> </u>	i .	H	X	REF	ILLEGAL	
	_	ı	i		oc	MRS	ILLEGAL	
Vrite	<u>-</u> Н	Υ	X	X	X	DESL	NOP	
ecovering	<u> </u>	H	Н	H	X	NOP	NOP	
ecovering	<u> </u>	H	H		X	BST	ILLEGAL	2
		H	ı	<u>-</u> Н	BA,CA,A10	RD/RDA	Begin read, determine AP	
	<u> </u>	п Н	<u> </u>	<u>п</u>	BA,CA,A10 BA,CA,A10	WR/WRA	Begin vrite, determine AP	
	<u> </u>	<u>П</u>	H	<u>∟</u> Н	BA,CA,A10 BA.RA	ACT	ILLEGAL	-
	L	L		П	,			2
	<u> </u>	<u> </u>	H	<u>L</u>	BA,A10	PRE/PALL	ILLEGAL	
	<u>L</u>	<u>L</u>	<u>L</u>	H	X	REF	ILLEGAL	
	L 	L	L	L	OC .	MRS	ILLEGAL	
Refreshing	H	X	X	X	X	DESL	NOP, idle after tARFC	
	L	Н	Н	Н	X	NOP	NOP, idle after tARFC	
	L	Н	Н	L	Х	BST	ILLEGAL	
	L	Н	L	Н	BA,CA,A10	RD/RDA	ILLEGAL	
	L	Н	L	L	BA,CA,A10	WR/WRA	ILLEGAL	
	L	L	Н	Н	BA,RA	ACT	ILLEGAL	
	L	L	Н	L	BA,A10	PRE/PALL	ILLEGAL	
	L	L	L	Н	X	REF	ILLEGAL	
	<u> L</u>	L	L	L	OC	MRS	ILLEGAL	
Mode register	H	Χ	Χ	Χ	Χ	DESL	NOP, idle after tMRD	
accessing	L	Н	Н	Н	Χ	NOP	NOP, idle after tMRD	
J	L	H	Н	L	Χ	BST	ILLEGAL	
	L	H	L	Н	BA,CA,A10	RD/RDA	ILLEGAL	
	L	Н	L	L	BA,CA,A10	WR/WRA	ILLEGAL	
	L	L	Н	Н	BA,RA	ACT	ILLEGAL	
	L	L	Н	L	BA,A10	PRE/PALL	ILLEGAL	
	L	L	L	Н	X	REF	ILLEGAL	
	1	ì	ì	i	oc	MRS	ILLEGAL	

Notes:

- 1. All entries assumes that CKE was High during the preceding clock cycle and the current clock cycle.I
- 2. LLEGAL to the bank in specified state; function may be legal in the bank indicated by BA, depending on the state of that bank
- 3. Must satisfy bus contention, bus turn around, write recovery requirements.
- 4. NOP to bank precharging or in idle state. May precharge bank indicated by BA.
- 5. ILLEGAL if any bank is not idle.
 - ILLEGAL: Device operation and/or data-integrity are not guaranteed.



15. MODE REGISTER FIELD TABLE TO PROGRAM MODES

Register Programmed with Normal MRS

Address	BA0	BA1	A11	A10/AP	A9	A8	A7	A6	A5	A4	A3	A2	A1	A0
Function	0	0	0	0	WB	0	0	CAS Latency		вт	Bur	st Len	gth	

15.1. MRS Mode

CAS Latency			В	urst Type	Burst Length					Write Burst Mode		
A6	A5	A4	Latency	A3	Type	A2	A1	A0	BT=0	BT=1	A9	Type
0	0	0	Reserved	0	Sequential	0	0	0	1	1	0	Programmed Burst Length
0	0	1	Reserved	1	Interleave	0	0	1	2	2	1	Single Location Access
0	1	0	2			0	1	0	4	4		
0	1	1	3			0	1	1	8	8		
1	0	0	Reserved			1	0	0	Reserved	Reserved		
1	0	1	Reserved			1	0	1	Reserved	Reserved		
1	1	0	Reserved			1	1	0	Reserved	Reserved		
1	1	1	Reserved			1	1	1	Full Page	Reserved		

15.2. BURST SEQUENCE

BURST LENGTH	STARTING COLUMN	ORDER OF ACCESSES WITHIN A BURST					
BOKOT ELNOTTI	ADDRESS	TYPE=SEQUENTIAL	TYPE=INTERLEAVED				
	A0						
2	0	0-1	0-1				
	1	1-0	1-0				
	A1 A0						
	0 0	0-1-2-3	0-1-2-3				
4	0 1	1-2-3-0	1-0-3-2				
	1 0	2-3-0-1	2-3-0-1				
	1 1	3-0-1-2	3-2-1-0				
	A2 A1 A0						
	0 0 0	0-1-2-3-4-5-6-7	0-1-2-3-4-5-6-7				
	0 0 1	1-2-3-4-5-6-7-0	1-0-3-2-5-4-7-6				
	0 1 0	2-3-4-5-6-7-0-1	2-3-0-1-6-7-4-5				
8	0 1 1	3-4-5-6-7-0-1-2	3-2-1-0-7-6-5-4				
	1 0 0	4-5-6-7-0-1-2-3	4-5-6-7-0-1-2-3				
	1 0 1	5-6-7-0-1-2-3-4	5-4-7-6-1-0-3-2				
	1 1 0	6-7-0-1-2-3-4-5	6-7-4-5-2-3-0-1				
	1 1 1	7-0-1-2-3-4-5-6	7-6-5-4-3-2-1-0				
Full Page (y)	N=A0 - A9 (x8) N=A0 - A8 (x16) (location 0 - y)	Cn, Cn+1, Cn+2, Cn+3, Cn+4,Cn-1, Cn	Not Supported				

Note:

- 1. For full-page accesses: y = 1023(x8), 511(x16).
- For a burst length of two, A1–A9(A8) select the block-of-two burst; A0 selects the starting column within the block.
 For a burst length of four, A2–A9(A8) select the block-of-four burst; A0–A1 select the starting column within the block.
- 4. For a burst length of eight, A3–A9(A8) select the block-of-eight burst; A0–A2 select the starting column within the block.
- 5. For a full-page burst, the full row is selected and –A9(A8) select the starting column.
- 6. Whenever a boundary of the block is reached within a given sequence above, the following access wraps within the block.
- 7. For a burst length of one, A0–A9(A8) select the unique column to be accessed, and mode register bit A3 is ignored.



16. POWER-UP SEQUENCE

16.1. Power-up sequence

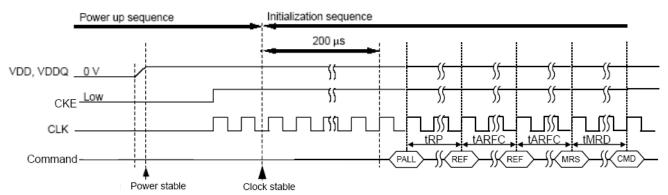
- 1. Apply VDD and VDDQ at the same time. Keep CKE low during power up.
- 2. Wait for stable power.
- 3. Start clock and drive CKE high.

Note: Voltage on any input pin must not exceed VDD+0.3V during power up.

16.2. Initialization sequence

- 1. After stable power and stable clock, wait 200us.
- 2. Issue precharge all command (PALL).
- 3. After tRP delay, set 2 or more auto refresh commands (REF).
- 4. Set the mode register set command (MRS) to initialize the mode register.

Note: We recommend that you keep DQM and CKE high during initialization sequence to prevent data contention on the DQ bus.



Power-up sequence and Initialization sequence

BL : Burst Length /CAS Latency = 2



17. OPERATION OF THE SDRAM

17.1. Read/Write Operations

17.1.1. Bank active

Before executing a read or write operation, the corresponding bank and the row address must be activated by the bank active (ACT) command. An interval of tRCD is required between the bank active command input and the following read/write command input.

17.1.2. Read operation

BL = 2

BI = 4

DΩ

A read operation starts when a read command is input. Output buffer becomes Low-Z in the (/CAS Latency - 1) cycle after read command set. The SDRAM can perform a burst read operation.

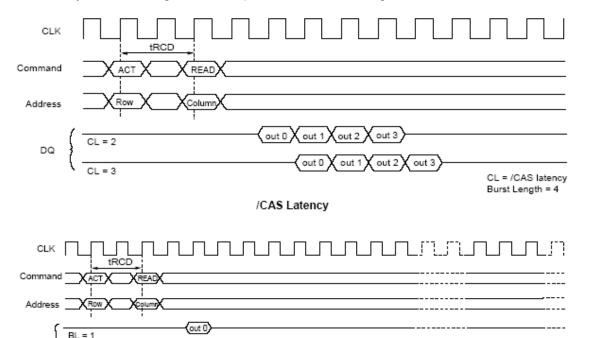
The burst length can be set to 1, 2, 4 and 8. The start address for a burst read is specified by the column address and the bank select address at the read command set cycle. In a read operation, data output starts after the number of clocks specified by the /CAS Latency. The /CAS Latency can be set to 2 or 3.

When the burst length is 1, 2, 4 and 8 the DOUT buffer automatically becomes High-Z at the next clock after the successive burst-length data has been output.

The /CAS latency and burst length must be specified at the mode register.

out 0X out 1)

out 0x out 1x out 2x out 3



Burst Length

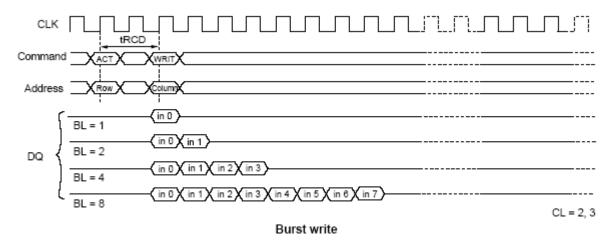
out 0Xout 1Xout 2Xout 3Xout 4Xout 5Xout 6Xout 7)



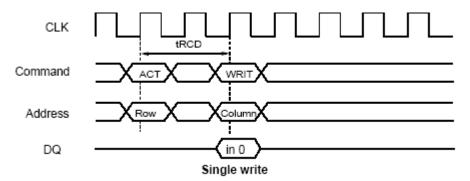
17.2. Write operation

17.2.1. Burst write or single write mode is selected

1. Burst write: A burst write operation is enabled by setting OPCODE A9 to 0. A burst write starts in the same clock as a write command set. (The latency of data input is 0 clock.) The burst length can be set to 1, 2, 4 and 8, like burst read operations. The write start address is specified by the column address and the bank select address at the write command set cycle.



2. Single write: A single write operation is enabled by setting OPCODE A9 to 1. In a single write operation, data is only written to the column address and the bank select address specified by the write command set cycle without regard to the burst length setting. (The latency of data input is 0 clock).





17.3. Auto Precharge

17.3.1. Read with auto-precharge

In this operation, since precharge is automatically performed after completing a read operation, a precharge command need not be executed after each read operation. The command executed for the same bank after the execution of this command must be the bank active (ACT) command.

The next ACT command can be issued at the later time of either tRP after internal precharge or tRC after the previous ACT.

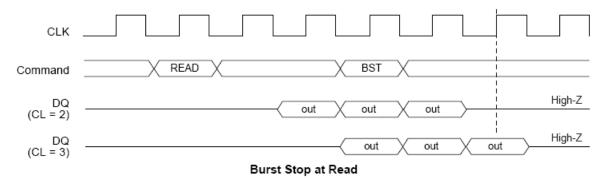
17.3.2. Write with auto-precharge

In this operation, since precharge is automatically performed after completing a burst write or single write operation, a precharge command need not be executed after each write operation. The command executed for the same bank after the execution of this command must be the bank active (ACT) command.

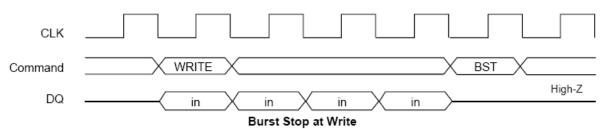
The next ACT command can be issued at the later time of either tDAL from the last input data cycle or tRC after the previous ACT.

17.4. Burst Stop Command

During a read cycle, when the burst stop command is issued, the burst read data are terminated and the data bus goes to High-Z after the /CAS latency from the burst stop command.



During a write cycle, when the burst stop command is issued, the burst write data are terminated and data bus goes to High-Z at the same clock with the burst stop command.

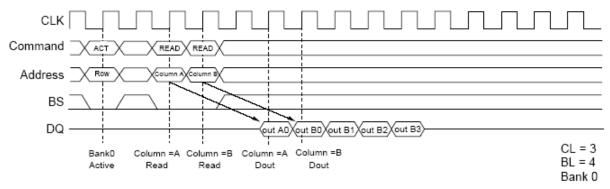




18. COMMAND INTERVALS

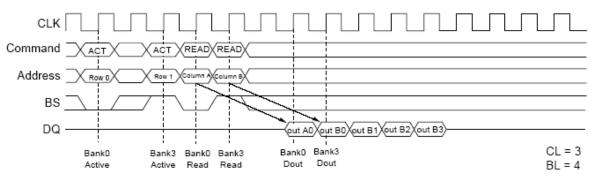
18.1. Read command to Read command interval

 Same bank, same ROW address: When another read command is executed at the same ROW address of the same bank as the preceding read command execution, the second read can be performed after an interval of no less than 1 clock. Even when the first command is a burst read that is not yet finished, the data read by the second command will be valid.



READ to READ Command Interval (same ROW address in same bank)

- 2. Same bank, different ROW address: When the ROW address changes on same bank, consecutive read commands cannot be executed; it is necessary to separate the two read commands with a precharge command and a bank active command.
- 3. Different bank: When the bank changes, the second read can be performed after an interval of no less than 1 clock, provided that the other bank is in the bank active state. Even when the first command is a burst read that is not yet finished, the data read by the second command will be valid.

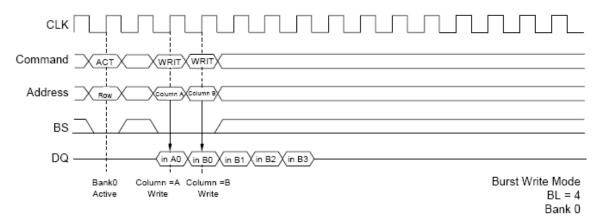


READ to READ Command Interval (different bank)



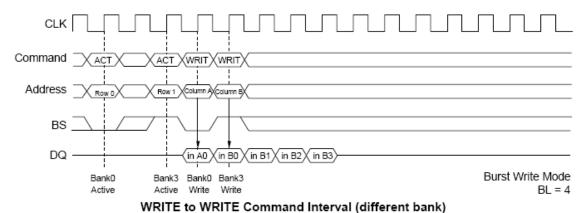
18.2. Write command to Write command interval

1. Same bank, same ROW address: When another write command is executed at the same ROW address of the same bank as the preceding write command, the second write can be performed after an interval of no less than 1 clock. In the case of burst writes, the second write command has priority.



WRITE to WRITE Command Interval (same ROW address in same bank)

- 2. Same bank, different ROW address: When the ROW address changes, consecutive write commands cannot be executed; it is necessary to separate the two write commands with a precharge command and a bank active command.
- 3. Different bank: When the bank changes, the second write can be performed after an interval of no less than 1 clock, provided that the other bank is in the bank active state. In the case of burst write, the second write command has priority.

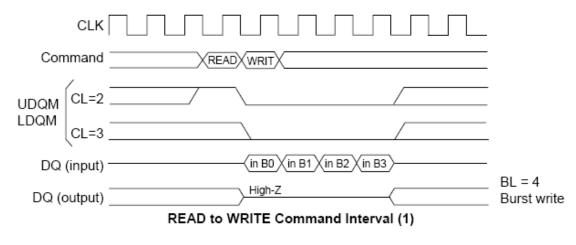


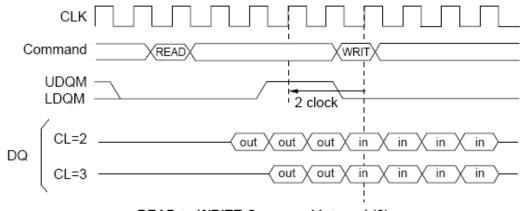
22



18.3. Read command to Write command interval

 Same bank, same ROW address: When the write command is executed at the same ROW address of the same bank as the preceding read command, the write command can be performed after an interval of no less than 1 clock. However, DQMU and DQML must be set High so that the output buffer becomes High-Z before data input.





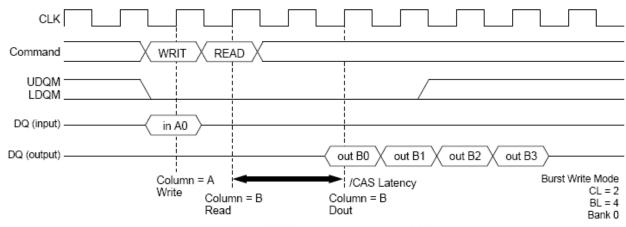
READ to WRITE Command Interval (2)

- 2. Same bank, different ROW address: When the ROW address changes, consecutive write commands cannot be executed; it is necessary to separate the two commands with a precharge command and a bank active command.
- 3. Different bank: When the bank changes, the write command can be performed after an interval of no less than 1 cycle, provided that the other bank is in the bank active state. However, DQMU and DQML must be set High so that the output buffer becomes High-Z before data input.

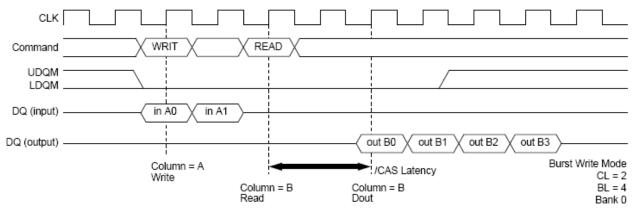


18.4. Write command to Read command interval:

 Same bank, same ROW address: When the read command is executed at the same ROW address of the same bank as the preceding write command, the read command can be performed after an interval of no less than 1 clock. However, in the case of a burst write, data will continue to be written until one clock before the read command is executed.



WRITE to READ Command Interval (1)



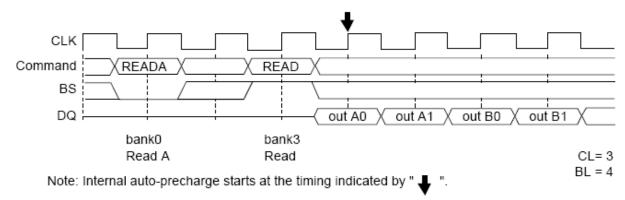
WRITE to READ Command Interval (2)

- 2. Same bank, different ROW address: When the ROW address changes, consecutive read commands cannot be executed; it is necessary to separate the two commands with a precharge command and a bank active command.
- 3. Different bank: When the bank changes, the read command can be performed after an interval of no less than 1 clock, provided that the other bank is in the bank active state. However, in the case of a burst write, data will continue to be written until one clock before the read command is executed (as in the case of the same bank and the same address).



18.5. Read with auto precharge to Read command interval (concurrent auto-precharge)

 Different bank: When some banks are in the active state, the second read command (another bank) is executed. Even when the first read with auto-precharge is a burst read that is not yet finished, the data read by the second command is valid. The internal auto-precharge of one bank starts at the clock of the second command.

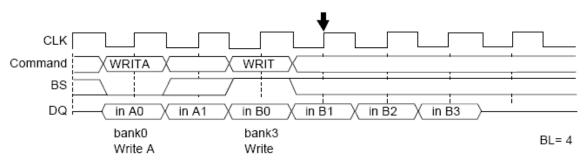


Read with Auto Precharge to Read Command Interval (Different bank)

2. Same bank: The consecutive read command (the same bank) is illegal.

18.6. Write with auto precharge to Write command interval (concurrent auto-precharge)

1. Different bank: When some banks are in the active state, the second write command (another bank) is executed. In the case of burst writes, the second write command has priority. The internal auto-precharge of one bank starts at the next clock of the second command.



Note: Internal auto-precharge starts at the timing indicated by " 👃 ".

Write with Auto Precharge to Write Command Interval (Different bank)

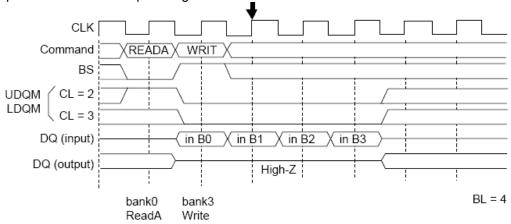
2. Same bank: The consecutive write command (the same bank) is illegal.



18.7. Read with auto precharge to Write command interval

(concurrent auto-precharge)

1. Different bank: When some banks are in the active state, the second write command (another bank) is executed. However, DQMU and DQML must be set High so that the output buffer becomes High-Z before data input. The internal auto-precharge of one bank starts at the clock of the second command.



Note: Internal auto-precharge starts at the timing indicated by " ... "

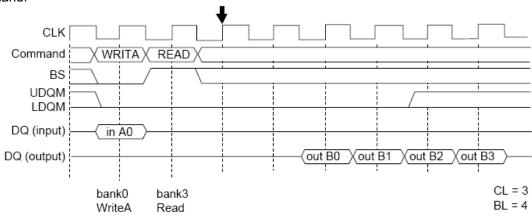
Read with Auto Precharge to Write Command Interval (Different bank)

2. Same bank: The consecutive write command from read with auto precharge (the same bank) is illegal. It is necessary to separate the two commands with a bank active command.

18.8. Write with auto precharge to Read command interval

(concurrent auto-precharge)

1. Different bank: When some banks are in the active state, the second read command (another bank) is executed. However, in case of a burst write, data will continue to be written until one clock before the read command is executed. The internal auto-precharge of one bank starts at the next clock of the second command.



Note: Internal auto-precharge starts at the timing indicated by " ... "

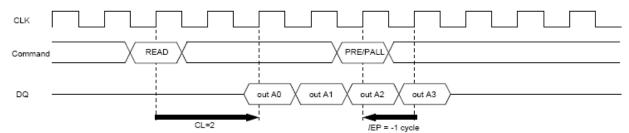
Write with Auto Precharge to Read Command Interval (Different bank)

2. Same bank: The consecutive read command from write with auto precharge (the same bank) is illegal. It is necessary to separate the two commands with a bank active command.

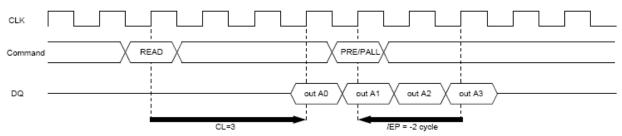


18.9. Read command to Precharge command interval (same bank)

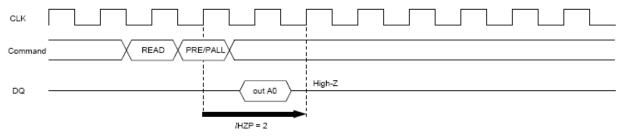
When the precharge command is executed for the same bank as the read command that preceded it, the minimum interval between the two commands is one clock. However, since the output buffer then becomes High-Z after the clocks defined by IHZP, there is a case of interruption to burst read data output will be interrupted, if the precharge command is input during burst read. To read all data by burst read, the clocks defined by IEP must be assured as an interval from the final data output to precharge command execution.



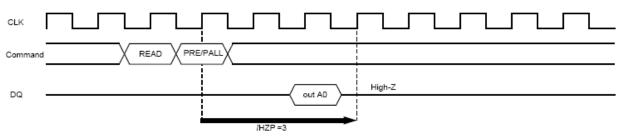
READ to PRECHARGE Command Interval (same bank): To output all data (CL = 2, BL = 4)



READ to PRECHARGE Command Interval (same bank): To output all data (CL = 3, BL = 4)



READ to PRECHARGE Command Interval (same bank): To stop output data (CL = 2, BL = 1, 2, 4, 8)

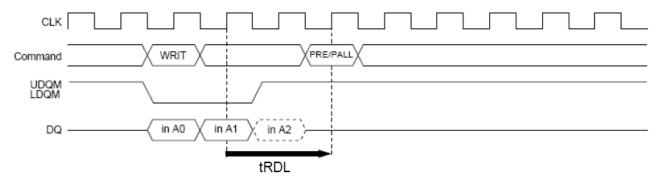


READ to PRECHARGE Command Interval (same bank): To stop output data (CL = 3, BL = 1, 2, 4, 8)

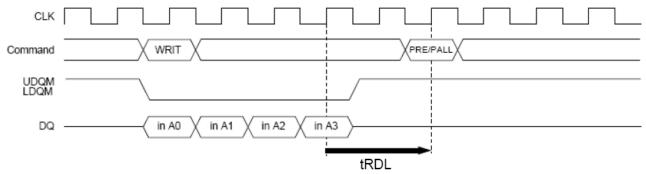


18.10. Write command to Precharge command interval (same bank)

When the precharge command is executed for the same bank as the write command that preceded it, the minimum interval between the two commands is 1 clock. However, if the burst write operation is unfinished, the input data must be masked by means of DQMU and DQML for assurance of the clock defined by tRDL.



WRITE to PRECHARGE Command Interval (same bank) (BL = 4 (To stop write operation))

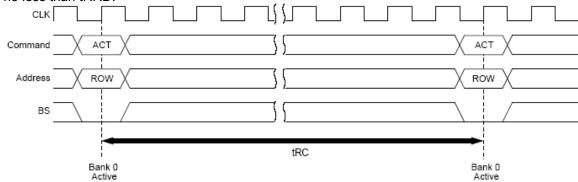


WRITE to PRECHARGE Command Interval (same bank) (BL = 4 (To write all data))

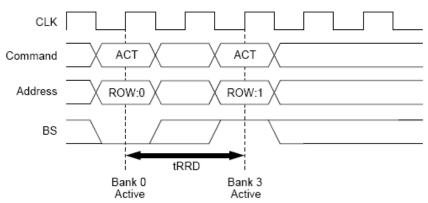


18.11. Bank active command interval

- 1. Same bank: The interval between the two bank active commands must be no less than tRC.
- 2. In the case of different bank active commands: The interval between the two bank active commands must be no less than tRRD.



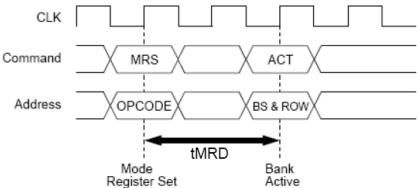
Bank Active to Bank Active for Same Bank



Bank Active to Bank Active for Different Bank

Mode register set to Bank active command interval

The interval between setting the mode register and executing a bank active command must be no less than tMRD.



Mode register set to Bank active command interval



18.12. DQM Control

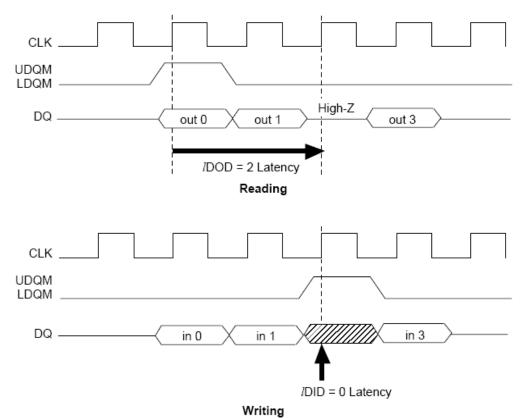
The DQMU and DQML mask the upper and lower bytes of the DQ data, respectively. The timing of DQMU and DQML is different during reading and writing.

18.12.1. Reading

When data is read, the output buffer can be controlled by DQMU and DQML. By setting DQMU and DQML to Low, the output buffer becomes Low-Z, enabling data output. By setting DQMU and DQML to High, the output buffer becomes High-Z, and the corresponding data is not output. However, internal reading operations continue. The latency of DQMU and DQML during reading is 2 clocks.

18.12.2. Writing

Input data can be masked by DQMU and DQML. By setting DQM to Low, data can be written. In addition, when DQMU and DQML are set to High, the corresponding data is not written, and the previous data is held. The latency of DQMU and DQML during writing is 0 clock.





18.13. Refresh

18.13.1. Auto-refresh

All the banks must be precharged before executing an auto-refresh command. Since the auto-refresh command updates the internal counter every time it is executed and determines the banks and the ROW addresses to be refreshed, external address specification is not required. The refresh cycles are required to refresh all the ROW addresses within tREF (max.).

The output buffer becomes High-Z after auto-refresh start. In addition, since a precharge has been completed by an internal operation after the auto-refresh, an additional precharge operation by the precharge command is not required.

18.13.2. Self-refresh

After executing a self-refresh command, the self-refresh operation continues while CKE is held Low. During self-refresh operation, all ROW addresses are refreshed by the internal refresh timer. A self-refresh is terminated by a self-refresh exit command. Before and after self-refresh mode, execute auto-refresh to all refresh addresses in or within tREF(max.) period on the condition 1 and 2 below.

- 1. Enter self-refresh mode within time as below* after either burst refresh or distributed refresh at equal interval to all refresh addresses are completed.
- 2. Start burst refresh or distributed refresh at equal interval to all refresh addresses within time as below* after exiting from self-refresh mode.

Note: tREF(max.) / refresh cycles.

18.14. Others

18.14.1. Power-down mode

The SDRAM enters power-down mode when CKE goes Low in the IDLE state. In power down mode, power consumption is suppressed by deactivating the input initial circuit. Power down mode continues while CKE is held Low. In addition, by setting CKE to High, the SDRAM exits from the power down mode, and command input is enabled from the next clock. In this mode, internal refresh is not performed.

18.14.2. Clock suspend mode

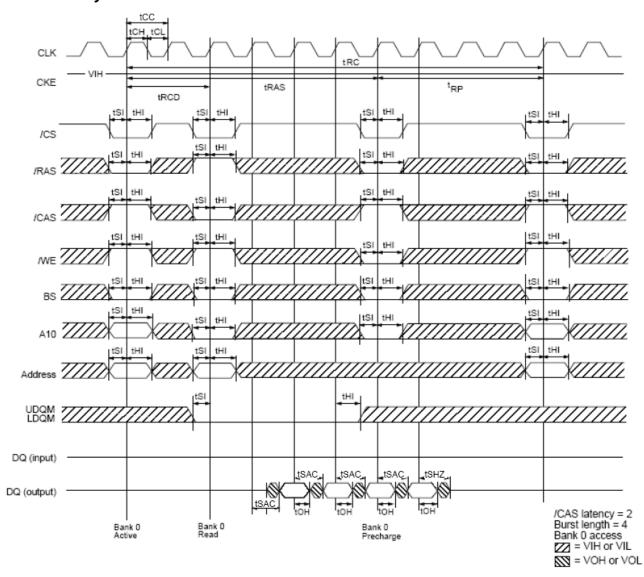
By driving CKE to Low during a bank active or read/write operation, the SDRAM enters clock suspend mode. During clock suspend mode, external input signals are ignored and the internal state is maintained. When CKE is driven High, the

SDRAM terminates clock suspend mode, and command input is enabled from the next clock. For details, refer to the "CKE Truth Table".



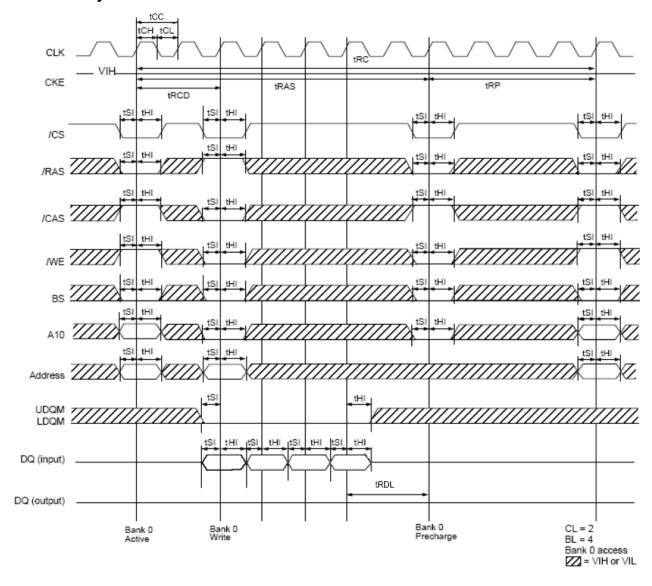
19. TIMING WAVEFORMS

19.1. Read Cycle



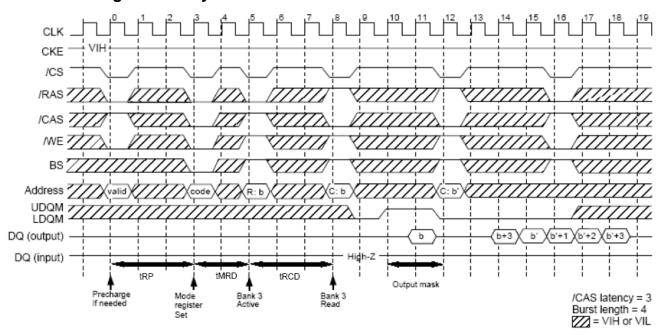


19.2. Write Cycle

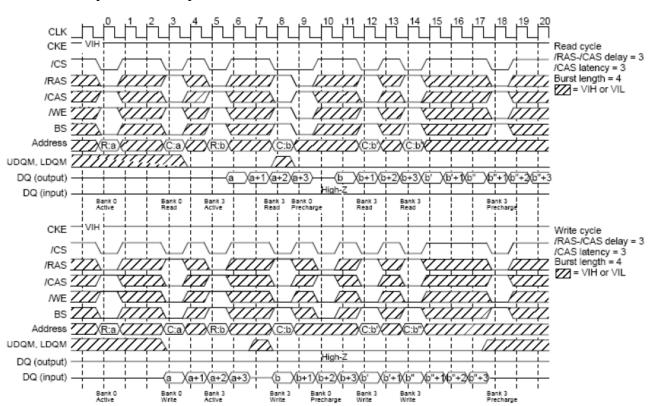




19.3. Mode Register Set Cycle

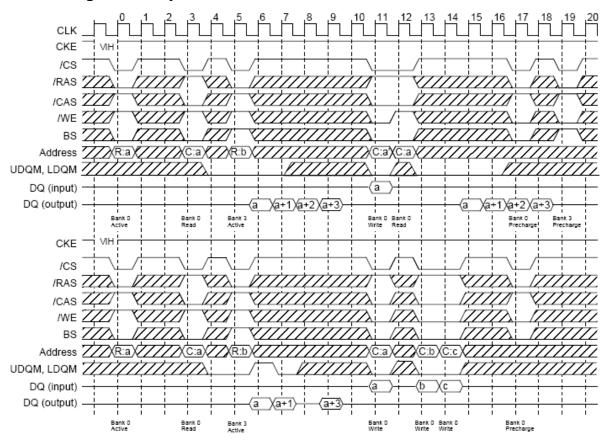


19.4. Read Cycle/Write Cycle





19.5. Read/Single Write Cycle

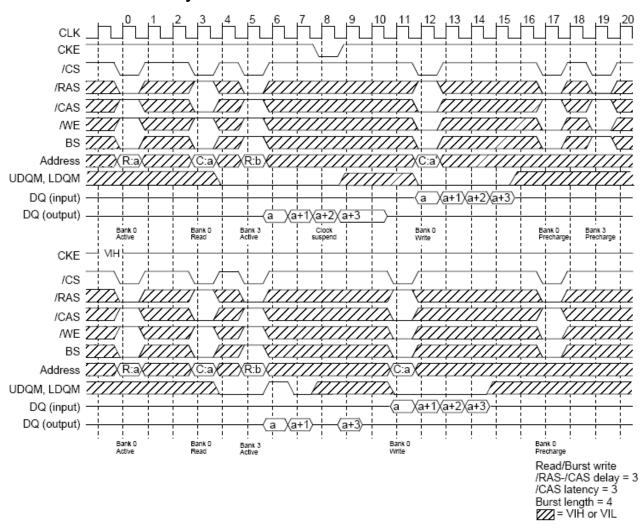


Read/Single write
/RAS-/CAS delay = 3
/CAS latency = 3
Burst length = 4

VIH or VIL

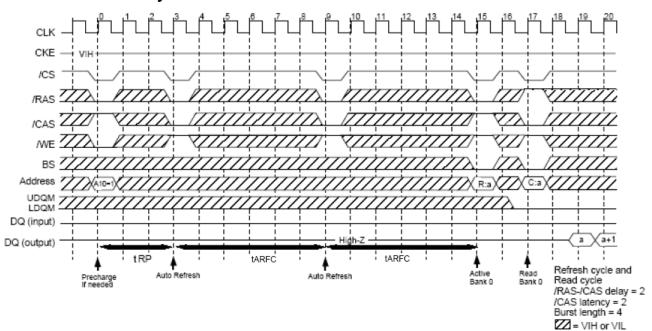


19.6. Read/Burst Write Cycle

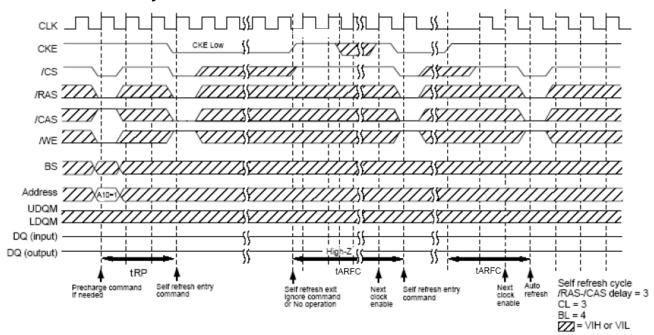




19.7. Auto Refresh Cycle

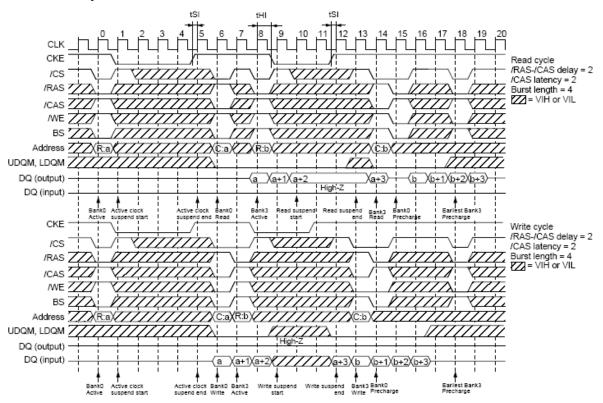


19.8. Self Refresh Cycle



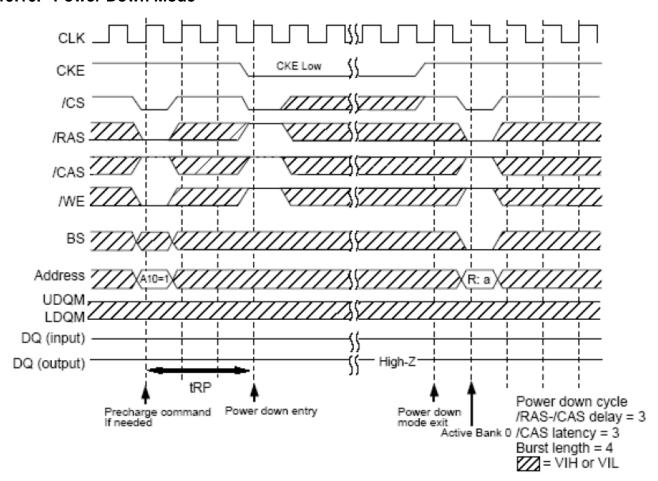


19.9. Clock Suspend Mode

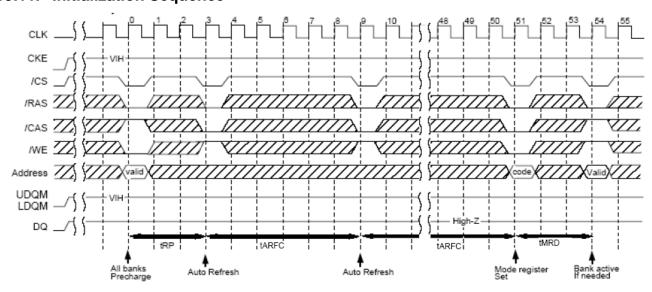




19.10. Power Down Mode



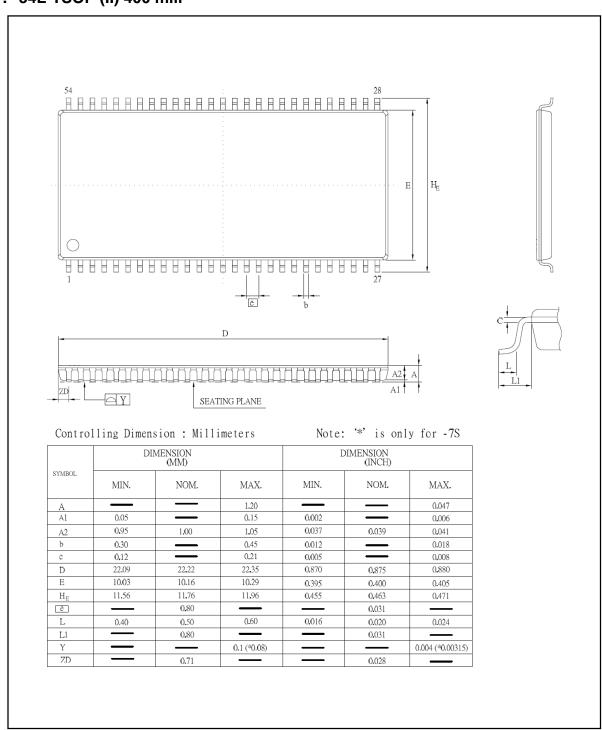
19.11. Initialization Sequence





20. PACKAGE DIMENSIONS

20.1. 54L-TSOP (II) 400 mill





21. REVISION HISTORY

VERSION	DATE	PAGE	DESCRIPTION
A00	2010/07/02	_	Preliminary datasheet
A01	2011/1/18	8	Modify IOH, IOL

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